EGT3 ENGINEERING TRIPOS PART IIA

CRIB

Module 3F8

INFERENCE

STATIONERY REQUIREMENTS

SPECIAL REQUIREMENTS TO BE SUPPLIED FOR THIS EXAM

10 minutes reading time is allowed for this paper.

You may not start to read the questions printed on the subsequent pages of this question paper until instructed to do so.

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1(a) Explain what is maximum likelihood estimation and how it is used to estimateparameters in a probabilistic model from data.[20%]

a) let dete be denoted Y = & 2n3n=1
parameters denoted O

$$p(Y|\theta) = probability of data given parameters
likelihood of the parameters
Maximum likelihood estimates for the parameters, OmL, we found via$$

 $\theta_{\mu l} = a_{\mu} max p(y|\theta) = a_{\mu} max log p(y|\theta)$

(b) A source emits *N* signals x_n drawn independently from a Gaussian distribution with mean 1 and variance 1. The signals are measured by a receiver a fixed distance *d* metres away. The signals are exponentially attenuated and corrupted by independent Gaussian noise so that the measurements are given by $y_n = \exp(-d)x_n + \varepsilon_n$. The noise ε_n has zero mean and variance 1.

The formula for a one dimensional Gaussian distribution with mean μ and variance σ^2 is

$$p(y|\boldsymbol{\mu}, \boldsymbol{\sigma}^2) = \frac{1}{\sqrt{2\pi\sigma^2}} \exp\left(-\frac{1}{2\sigma^2}(y-\boldsymbol{\mu})^2\right).$$

(i) Compute the mean and the variance of a single measurement y_n under the probabilistic model. [30%]

b)
$$y_{n} = W \times x_{n} + \varepsilon_{n}$$
 where $W = e^{-d}$ $\varepsilon_{n} \wedge N(0,1) \times N(1,1)$
i) $\mathbb{E}_{p(x_{n},\varepsilon_{n})} \begin{bmatrix} y_{n} \end{bmatrix} = W \mathbb{E}_{[x_{n}]} + \mathbb{E}_{[z_{n}]} \\ = W = e^{-d} = \mu_{y}$
 $\mathbb{E}_{p(x_{n},\varepsilon_{n})} \begin{bmatrix} y_{n}^{2} \end{bmatrix} = \mathbb{E}_{p(x_{n},\varepsilon_{n})} \begin{bmatrix} U \times x_{n} + \varepsilon_{n} \end{bmatrix}^{2}$
 $= W \frac{1}{p(x_{n},\varepsilon_{n})} \begin{bmatrix} w_{n}^{2} + 2W \times x_{n} \\ \varepsilon_{n} + \varepsilon_{n}^{2} \end{bmatrix}$
 $= W^{2} \mathbb{E}_{p(x_{n},\varepsilon_{n})} \begin{bmatrix} x_{n}^{2} \end{bmatrix} + 2W \mathbb{E}_{p(x_{n})} \begin{bmatrix} x_{n} \end{bmatrix} \mathbb{E}_{p(z_{n})} \\ + \mathbb{E}_{p(z_{n})} \\ \mathbb{E}_{p(z_{n})} \end{bmatrix}$
 $= U^{2} \times 2 + 0 + 1$
Variance is given by
 $\overline{v_{y}}^{2} = \mathbb{E}_{p(x_{n},\varepsilon_{n})} \begin{bmatrix} y_{n}^{2} \end{bmatrix} - \left(\mathbb{E}_{p(x_{n},\varepsilon_{n})} \begin{bmatrix} y_{n} \end{bmatrix}\right)^{2} = W^{2} + (1 + 1)$

(ii) Use your answer to (i) to compute the likelihood of the parameter *d* when *N* measurements have been made. [20%]

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(iii) Four measurements are made $\{y_n\}_{n=1}^N = \{1, -2, -1, 2\}$. Find the maximum likelihood setting of the parameter *d* for these data. You may find it simpler to first find the maximum likelihood setting for $w = \exp(-d)$ and then rearrange to find the estimate of *d*. [30%]

iii)
$$\log \beta(y_{1:N}(w)) = -\frac{N}{2} \log (2\pi (1+w^2)) - \frac{1}{2(1+w^2)} \sum_{n=1}^{\infty} (y_n - w)^2$$

 $= -\frac{N}{2} \log (2\pi (1+w^2)) - \frac{1}{2(1+w^2)} \left[\sum_{n=1}^{\infty} y_n^2 - 2w \sum_{n=1}^{\infty} y_n + Nw^2 \right]$
in our case
 $\sum_{n=1}^{\infty} y_n = 0$ $\sum_{n=1}^{\infty} y_n^2 = 1 + 4 + 1 + 4 = 10$ $N = 4$
 $\therefore \log \rho(y_{1:N}(w)) = -2 \log (2\pi (1+w^2)) - \frac{1}{2(1+w^2)} \left[10 + 4w^2 \right]$
 $0 = \frac{d}{dw} \log \rho(y_{1:N}(w)) = -\frac{2 \cdot 2w}{1+w^2} + \frac{1}{2(1+w^2)^2} \cdot 2w \left[10 + 4w^2 \right]$
 $0 = \frac{d}{dw} \log \rho(y_{1:N}(w)) = -\frac{2 \cdot 2w}{1+w^2} + \frac{1}{2(1+w^2)^2} \cdot 2w \left[10 + 4w^2 \right]$
 $0 = -8 w (1+w^2) + w (10 + 4w^2)$
 $w = 0$ is a minimum

$$0 = 2 - 4 \ \omega^{2}$$

=) $\omega_{\mu L} = \int_{2}^{1} \frac{1}{2} = 0.347$
(3 st)

Assessor's comments: The most popular question (all but two candidates attempted it). Generally very well answered, but it was clear that some candidates spent a large amount of time on this question.

2 (a) Compare and contrast *regression* and *classification* tasks in machine learning.

a) in both regionin & classification you get given a training set of input /output
pairs
$$\frac{2}{2} \times n$$
, $\frac{2}{3} n \frac{3}{n-1}$ and the good is to predict outputs $\frac{1}{7}$ associated
inputs outputs with unseen (new) inputs $\frac{1}{2}$.
To seeve in the fit outputs input inputs of $\frac{1}{7}$.

(b) A dataset comprises pairs of real valued inputs x_n and real valued outputs y_n shown in Fig. 1. Suggest a suitable probabilistic model for these data that could be used to predict an output from new input. Explain your reasoning. [30%]

[30%]

(c) A second set of discrete valued outputs z_n , shown in Fig. 2, were measured simultaneously with y_n so that the training data is now $\{x_n, y_n, z_n\}_{n=1}^N$. Extend the probabilistic model you proposed for part (b) so that it can be used to jointly predict both outputs from a new input. Explain your reasoning. [30%]

c) Assumption:
$$y_n 42n$$
 are independent guin x_n
Note: $z_n \in \{2, 1, 2, 3\}$ i.e. takes disorte values \therefore suggest
 $p(2_n = k \mid \pi_n) = \underbrace{e^{\bigcup_{k=1}^{W_k} Y(k_n) + b_k}}_{\substack{\{2 = 1\}}}$ (softmax)
 $\underbrace{\sum_{i=1}^{V_k} e^{\bigcup_{k=1}^{W_k} Y(k_n) + b_k}}_{\substack{\{2 = 1\}}}$
Linear basis functions will not be sufficient here since class 1
occurs around $2c_n 220 \notin 804 \times n$. Bradatic, or some other
Servible non-linear basis function would be appropriate i.e. $Y(x_n) = \begin{bmatrix} x_n \\ x_n^2 \end{bmatrix}$
 $(=)$ multicless classification with nonlinear basis functions)

(offer sensible solutions are fine to)

(d) Consider the extended model you have proposed in part (c). Do the second set of outputs provide useful information about the parameters of the original component described in part (b)? Explain your reasoning. [10%]

d) The likelihood for the model desirited in parts blac above
$$i$$
:
The p($\frac{1}{2}n|\frac{1}{2}n,\frac{1}{2}n$

Assessor's comments: A large number of adequate solutions, but few were very good or very poor. Many candidates failed to identify that the second dataset in part (c) was a classification dataset. Some candidates wrote that classification and/or regression were examples of unsupervised learning, rather than supervised learning.

3 (a) Describe what *clustering* is and give an example application where a clustering algorithm might be used. [20%]

a) Clustering is an unsuperied martine learning problem in which data
$$\xi y_n 3_{n=1}^{\infty}$$

are assigned into one of a number of clusters $\xi S_n 3_{n=1}^{N}$ where $S_n \xi \xi 1, ..., K3$ insuchancey
that "near by" or "similar" data points are assigned to the same cluster and
"for any" or "dissimilar points are assigned to different clusters.
Example application : Segmentation of image pixels

(b) A simple one dimensional dataset, $\{y_n\}_{n=1}^N = \{-10.1, -9.9, 9.9, 10.1\}$, is modelled using a mixture of Gaussians. The mixture comprises two components with class membership probabilities $p(s_n = 1) = \alpha$ and $p(s_n = 2) = 1 - \alpha$. The component distributions are given by $p(y_n|s_n = 1, \theta) = \mathcal{N}(y_n; \mu_1, \sigma_1^2)$ and $p(y_n|s_n = 2, \theta) = \mathcal{N}(y_n; \mu_2, \sigma_2^2)$ where

$$\mathcal{N}(y;\mu,\sigma^2) = \frac{1}{\sqrt{2\pi\sigma^2}} \exp\left(-\frac{1}{2\sigma^2}(y-\mu)^2\right).$$

The parameters of the model are collectively denoted $\theta = \{\mu_1, \mu_2, \sigma_1^2, \sigma_2^2, \alpha\}.$

(i) The model is fitted using the Expectation Maximisation (EM) algorithm. The posterior distribution over the class labels for the *n*th data point is denoted $r_{n,k} = p(s_n = k | y_n)$. Write down the algorithm's M-Step update equations. [40%]

bi)
$$A_{k} = \sum_{n=1}^{N} \Gamma_{n} k y_{n}$$

 $T_{k} = \sum_{n=1}^{N} \Gamma_{n} k$
 $T_{k} = \sum_{N=1}^{N} \Gamma_{n} k$
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(ii) The EM algorithm is run to convergence returning a parameter estimate $\theta_{\rm EM}$. The estimate is found to depend on the initialisation. Sketch the various Gaussian mixture model fits that the EM algorithm returns, i.e. sketch the densities $p(y|\theta_{\rm EM})$ as a function of y. Where possible, indicate the estimated parameter values approximately. Identify which estimates correspond to global optima of the likelihood. [40%]





Assessor's comments: This question was the hardest one on the exam. Many candidates gave full derivations for the M-Step equations in part (bi). This was not asked for in the question and it was sufficient to write them directly. Some candidates struggled with part (bii) failing to identify that the maximum likelihood solutions will place a single Gaussian of zero width on one of the data points, and use the other Gaussian to model the remaining points.

4 (a) Explain what the terms *Markov property, filtering* and *stationary distribution* refer to in the context of *Hidden Markov Models*? [30%]

(b) A probabilistic model for a time-series containing binary valued observations y_n employs binary state variables s_n . The transition matrix and emission matrix of the model are denoted

$$T = \begin{bmatrix} p(s_{n+1} = 0|s_n = 0) & p(s_{n+1} = 0|s_n = 1) \\ p(s_{n+1} = 1|s_n = 0) & p(s_{n+1} = 1|s_n = 1) \end{bmatrix}, E = \begin{bmatrix} p(y_n = 0|s_n = 0) & p(y_n = 0|s_n = 1) \\ p(y_n = 1|s_n = 0) & p(y_n = 1|s_n = 1) \end{bmatrix}$$

The forward filtering recursions have been used to process N observations, $y_{1:N}$, in order to return the posterior distribution over the Nth state variable,

$$\boldsymbol{\rho} = \left[\begin{array}{c} p(s_N = 0 | y_{1:N}) \\ p(s_N = 1 | y_{1:N}) \end{array} \right].$$

(i) Explain how to transform the posterior distribution over the *N*th state into a forecast for the observations one time step into the future, i.e. express $p(y_{N+1}|y_{1:N})$ in terms of ρ . [25%]

bi)
$$p|y_{NH}|(y_{1:w}) = \underset{I}{\underline{E}} = p(s_{wH}|y_{1:w})$$

since $\underline{I}p = p(s_{wH}|y_{1:w})$

ii)

(ii) Now provide a forecast for the observations τ time steps into the future by expressing $p(y_{N+\tau}|y_{1:N})$ in terms of ρ . [15%]

$$p(y_{N+r}|y_{1:N}) = \underset{ince}{E} \underbrace{T}_{r} p$$

Since $\underbrace{T}_{r} p = p(s_{N+r}|y_{1:N})$

(iii) Compute the forecast $p(y_{N+\tau}|y_{1:N})$ in the limit $\tau \to \infty$ when

$$T = \begin{bmatrix} 3/4 & 1/2 \\ 1/4 & 1/2 \end{bmatrix}, E = \begin{bmatrix} 3/4 & 1/4 \\ 1/4 & 3/4 \end{bmatrix}.$$

Explain your reasoning.

Assessor's comments: Well answered in the main. A number of candidates could not define what filtering was. Some made analytic errors when calculating the stationary distribution of the hidden variables.

END OF PAPER

[30%]